

Application/Control No.	Applicant(s)/Patent under Reexamination
10/687,096	VOELZ, JAMES L.
Examiner	Art Unit
Sara W Crane	2811

SEARCHED					
Class	Subclass	Date	Examiner		
257	669	4105	SWC		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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